1	ž,						
,		Type	L #	Hits	Search Text	DBs	Time Stamp
	1	BRS	L1	948	wire adj bonding and (open or short) and (testing or test) and flip adj chip	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	
	2	BRS	L2	267	wire adj bonding and (open and short) and (testing or test) and flip adj chip	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/10 13:49
	3	BRS	L3	296		USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/10 14:02
	4	BRS	L4	47270	wire-bonded or wire-bonding or (wire adj bond\$6)	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/10 14:03
	5	BRS	L 5	124582 7	test or testing	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/10

	Туре	L #	Hits	Search Text	DBs	Time Stamp
6	BRS	L6	11148	open/short or (open near2 short)	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/10 14:03
7	BRS	L7	730	5 near8 6	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/10 14:03
8	BRS	L8	34		USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/10 14:04
9	BRS	L9	347354 1	test or testing or checked or checking or check or tested or examining or exam or determine or determing or determined or evaluate	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/10 14:17
10	BRS	L10	924	9 near4 6	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/10 14:17

	Туре	L #	Hits	Search Text	DBs	Time St
11	BRS	L11	10	10 same 4	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/ 14:20
12	BRS	L12	38	10 and 4	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/ 14:20
13	IS&R	L13	1	("6655023").PN.	USPAI	2004/03/ 14:28
14	IS&R	L14	1	("6433419").PN.	USPAT	2004/03/ 14:28
15	IS&R	L15	1	("6461896").PN.	USPAT	2004/03/ 14:28
16	BRS	L17	3	13 or 14 or 15	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03, 14:29
17	BRS	L19	7	4 with 6 with 9	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B	2004/03/ 14:32